

**Search Notes**

Application/Control No.

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Examiner

B. Dell Chism

Applicant(s)/Patent under  
Reexamination

BELTZER ET AL.

Art Unit

1654

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN (REGISTRY; CAPLUS; USPATFULL; BIOSIS; USPAT2)	8/18/2005	BDC